

**Notice of References Cited**

Application/Control No.

10/771,268

Applicant(s)/Patent Under  
Reexamination  
LIAO ET AL.

Examiner

Tung Q. Tran

Art Unit

2616

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0133411	06-2006	Denton et al.	370/463
*	B	US-2005/0025469	02-2005	Geer et al.	386/125
*	C	US-2002/0191543	12-2002	Buskirk et al.	370/230.1
*	D	US-6,222,848	04-2001	Hayward et al.	370/412
*	E	US-2005/0021807	01-2005	Van Eijndhoven et al.	709/231
*	F	US-6,496,519	12-2002	Russell et al.	370/465
*	G	US-6,788,658	09-2004	Bims, Harry	370/328
*	H	US-6,909,720	06-2005	Willis, Steven R.	370/395.52
*	I	US-2001/0040896	11-2001	Frouin et al.	370/466
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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